


<b>Search Notes</b>  	<b>Application/Control No.</b>  10575723	<b>Applicant(s)/Patent Under Reexamination</b>  KONNO ET AL.
	<b>Examiner</b>  Louis K Huynh	<b>Art Unit</b>  3721

SEARCHED			
Class	Subclass	Date	Examiner
53	373.7, 374.3, 374.5, 374.6, 375.9, 550, 551, 552	9/24/2007	LH
156	367	9/24/2007	LH
219	633	9/24/2007	LH
Updated	All above	4/23/2008	LH
Updated	All above	9/23/2008	LH

SEARCH NOTES		
Search Notes	Date	Examiner
Interference search in US-PAT & US-PGPUB databases - See printout	9/23/2008	LH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
53, 156, 219	All above	9/23/2008	LH

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